

Notice of References Cited	Application/Control No. 09/940,517		Applicant(s)/Patent Under Reexamination HOSHINO ET AL.	
	Examiner Christopher R. Magee		Art Unit 2653	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-4,800,454	01-1989	Schwarz et al.	360/234.5
*	C	US-5,712,747	01-1998	Voldman et al.	360/234.4
*	D	US-5,805,390 A	09-1998	Takeura, Tooru	360/323
*	E	US-6,181,531 B1	01-2001	Koshikawa et al.	360/294.4
*	F	US-6,477,006	11-2002	Sato, Kiyoshi	360/317
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*	N	JP 08-045033	02-1996	Japan	English Translation	---
*	O	JP 11-265503	09-1999	Japan	English Translation	---
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NON-PATENT DOCUMENTS

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*	U	Wu et al. "ESD Protection of GMR Heads in Manufacturing." 1999. SAE Magnetics (HK) Ltd. EOS/ESD SYMPOSIUM. pages 99-315 to 99-318.
*	V	IBM Technical Disclosure Bulletin. "Magnetoresistive Head with Integrated Varistor for ESD/EOS Protection." April 1, 2000. IBM. Issue Number 432. Page Number 751.
*	W	IBM Technical Disclosure Bulletin. "Magnetoresistive Head with Integrated Varistor Employing Combined Varistor, Antiferromagnetic Seed/Gap and Grounded First Shield." April 1, 2000. IBM. Issue Number 432. Page Number 751.
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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